

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/015,334	MIERNIK, JERZY W.	
	Examiner	Art Unit	Page 1 of 1
Huy D Nguyen	2681		

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	C	US-2002/0068565	06-2002	Purnadi et al.	455/436
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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